

## MOS FIELD EFFECT TRANSISTOR

# 2SK3431

### SWITCHING N-CHANNEL POWER MOS FET INDUSTRIAL USE

#### DESCRIPTION

The 2SK3431 is N-channel MOS Field Effect Transistor designed for high current switching applications.

#### FEATURES

- Super low on-state resistance:
- $R_{DS(on)1} = 5.6 \text{ m}\Omega \text{ MAX.} (V_{GS} = 10 \text{ V}, \text{ ID} = 42 \text{ A})$
- ★  $R_{DS(on)2} = 8.9 \text{ m}\Omega \text{ MAX.} (V_{GS} = 4 \text{ V}, \text{ ID} = 42 \text{ A})$
- ★ Low Ciss: Ciss = 6100 pF TYP.
  - Built-in gate protection diode

#### ABSOLUTE MAXIMUM RATINGS (TA = 25°C)

	•	•	
Drain to Source Voltage	VDSS	40	V
Gate to Source Voltage	Vgss	±20	V
Drain Current (DC)	D(DC)	±83	А
Drain Current (pulse) <sup>Note1</sup>	D(pulse)	±332	А
Total Power Dissipation (Tc = 25°C)	P⊤	100	W
Total Power Dissipation ( $T_A = 25^{\circ}C$ )	P⊤	1.5	W
Channel Temperature	Tch	150	°C
Storage Temperature	Tstg	-55 to +150	°C
Single Avalanche Current	las	65	А
Single Avalanche Energy	Eas	423	mJ

**Notes 1.** PW  $\leq$  10  $\mu$  s, Duty cycle  $\leq$  1 %

**2.** Starting T<sub>ch</sub> = 25 °C, R<sub>G</sub> = 25  $\Omega$ , V<sub>GS</sub> = 20 V  $\rightarrow$  0 V

#### **ORDERING INFORMATION**

PART NUMBER	PACKAGE
2SK3431	TO-220AB
2SK3431-S	TO-262
2SK3431-Z	TO-220SMD





(TO-220SMD)



#### THERMAL RESISTANCE

Channel to Case	Rth(ch-C)	1.25	°C/W
Channel to Ambient	Rth(ch-A)	83.3	°C/W

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The mark  $\star$  shows major revised points.

CHARACTERISTICS	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNI
Drain to Source On-state Resistance	RDS(on)1	$V_{GS} = 10 V$ , $I_D = 42 A$		4.5	5.6	mΩ
	RDS(on)2	Vgs = 4 V, Id = 42 A		6.2	8.9	mΩ
Gate to Source Cut-off Voltage	V <sub>GS(off)</sub>	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 1 mA	1.5	2.0	2.5	V
Forward Transfer Admittance	<b>y</b> fs	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 42 A	30	60		S
Drain Leakage Current	loss	$V_{DS} = 40 V, V_{GS} = 0 V$			10	μA
Gate to Source Leakage Current	lgss	$V_{GS} = \pm 20 V$ , $V_{DS} = 0 V$			±10	μA
Input Capacitance	Ciss	$V_{DS} = 10 V, V_{GS} = 0 V, f = 1 MHz$		6100		pF
Output Capacitance	Coss			1400		pF
Reverse Transfer Capacitance	Crss			700		pF
Turn-on Delay Time	td(on)	$I_D = 42 \text{ A}, V_{GS(on)} = 10 \text{ V}, V_{DD} = 20 \text{ V},$		120		ns
Rise Time	tr	R <sub>G</sub> = 10 Ω		1800		ns
Turn-off Delay Time	td(off)			350		ns
Fall Time	tr			440		ns
Total Gate Charge	QG	$I_D = 83 A$ , $V_{DD} = 32 V$ , $V_{GS} = 10 V$		110		nC
Gate to Source Charge	Q <sub>GS</sub>			18		nC
Gate to Drain Charge	Qgd			31		nC
Body Diode Forward Voltage	VF(S-D)	IF = 83 A, VGs = 0 V		1.0		V
Reverse Recovery Time	trr	IF = 83 A, VGs = 0 V,		65		ns
Reverse Recovery Charge	Qrr	di/dt = 100 A/µ s		110		nC

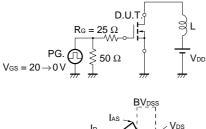
#### ELECTRICAL CHARACTERISTICS (TA = 25 °C)

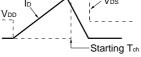
NEC

#### TEST CIRCUIT 1 AVALANCHE CAPABILITY

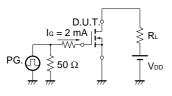
#### **TEST CIRCUIT 2 SWITCHING TIME**

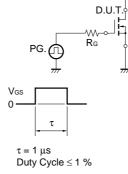
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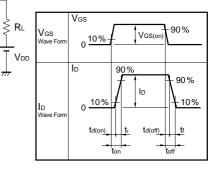




#### **TEST CIRCUIT 3 GATE CHARGE**



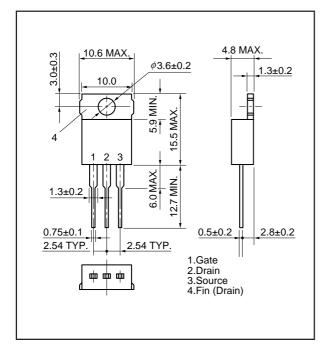




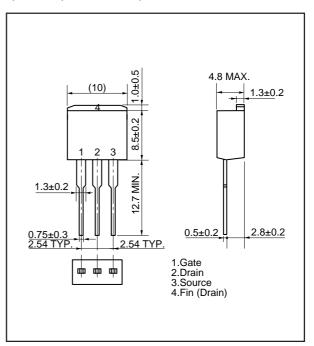
Preliminary Data Sheet D14600EJ1V0DS00

#### PACKAGE DRAWINGS (Unit: mm)

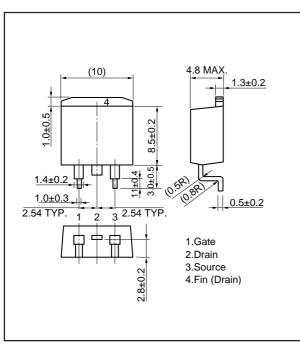
#### 1) TO-220AB (MP-25)



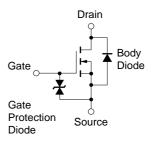
2) TO-262 (MP-25 Fin Cut)



#### 3) TO-220SMD (MP-25Z)



#### **EQUIVALENT CIRCUIT**



**Remark** The diode connected between the gate and source of the transistor serves as a protector against ESD. When this device actually used, an additional protection circuit is externally required if a voltage exceeding the rated voltage may be applied to this device.

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